# CMOS linear image sensor S8377/S8378 series

Built-in timing generator and signal processing circuit; 5 V single supply operation

S8377/S8378 series is a family of CMOS linear image sensors designed for image input applications. These linear image sensors operate from 5 V single supply with only start and clock pulse inputs, making them easy to use. The signal processing circuit has a charge amplifier with excellent input/output characteristics and allows signal readout at 500 kHz.

The photodiodes of S8377 series have a height of 0.5 mm and are arrayed in a row at a spacing of 50 µm. The photodiodes of S8378 series also have a height of 0.5 mm but are arrayed at a spacing of 25 µm. The photodiodes are available in 3 different pixel quantities for each series: 128 (S8377-128Q), 256 (S8377-256Q, S8378-256Q), 512 (S8377-512Q, S8378-512Q) and 1024 (S8378-1024Q). Quartz glass is the standard window material

## **Features**

Wide active area Pixel pitch: 50 µm (\$8377 series) 25 µm (\$8378 series)

Pixel height: 0.5 mm

- On-chip charge amplifier with excellent input/output characteristics
- Built-in timing generator allows operation with only start and clock pulse inputs
- Maximum operating clock frequency: 500 kHz
- Spectral response range: 200 to 1000 nm
- 5 V single power supply operation
- 8-pin small package, S8377 and S8378 series are pin compatible.

## **Applications**

- Image input devices
- Optical sensing devices

勝 特 力 材 料 886-3-5753170 胜特力电子(上海) 86-21-34970699 胜特力电子(深圳) 86-755-83298787

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Absolute maximum ratings

- Absolute maximum ratings			
Parameter	Symbol	Value	Unit
Supply voltage	Vdd	-0.3 to +10	V
Gain selection terminal voltage	Vg	-0.3 to +10	V
Clock pulse voltage	V(CLK)	-0.3 to +10	V
Start pulse voltage	V(ST)	-0.3 to +10	V
Operating temperature *1	Topr	-20 to +60	°C
Storage temperature*1	Tstg	-20 to +80	°C

<sup>\*1:</sup> No condensation

#### ■ Shape specifications

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Parameter	S8377- 128Q	S8377- 256Q	S8377- 512Q	S8378- 256Q	S8378- 512Q	S8378- 1024Q	Unit
Number of pixels	128	256	512	256	512	1024	·
Pixel pitch		50			25		μm
Pixel height			0	.5	1		mm
Package length	15.8	22.2	35.0	15.8	22.2	35.0	mm
Number of pins			(	8	110	1	4
Package			Cer	amic		1.	7
Window material			Qu	artz	1100		-



#### S8377/S8378 series **CMOS** linear image sensor

■ Recommended terminal voltage

Parameter		Symbol	Min.	Typ.	Max.	Unit
Supply voltage		Vdd	4.75	5	5.25	V
Gain selection	High gain	Vg	0	1 4 50	0.4	V
terminal voltage	Low gain	vg	Vdd - 0.25	Vdd	Vdd + 0.25	V
Clask pulse velters	High level	V(CLK)	Vdd - 0.25	Vdd	Vdd + 0.25	V
Clock pulse voltage	Low level	V(CLK)	0	1-1	0.4	V
Start pulse veltage	High level	WCT	Vdd - 0.25	Vdd	Vdd + 0.25	V
Start pulse voltage	Low level	V(ST)	0	100	0.4	V

## ■ Electrical characteristics

Parameter	Symbol	Min.	Typ.	Max.	Unit
Clock pulse frequency*2	f(CLK)	0.1 k		500 k	Hz
Output impedance*3	Zo	-	1	4-0	kΩ
Power consumption	P	-	15	100 2 10	mW

<sup>\*2:</sup> Ta=25 °C, Vdd=5 V, V(CLK)=V(ST)=5 V, Vg=5 V (Low gain)

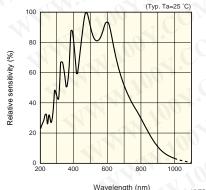
Use a JFET or CMOS input, high-impedance input op amp as the buffer amplifier.

Electrical and optical characteristics [Ta=25 °C, Vdd=5 V, V(CLK)=V(ST)=5 VI

Descriptor		Symbol	S8377 series		S8378 series			1 (1)	
Parameter	Parameter		Min.	Тур.	Max.	Min.	Тур.	Max.	Unit
Spectral response range		λ	1 ()	200 to 1000			200 to 1000	110	nm
Peak sensitivity wavelen	gth	λρ	-	500	-1	-	500	-	nm
Photo sensitivity	High gain Low gain	- S	- 4	22 4.4	-	-	22 4.4	- 1	$V/lx \cdot s$
Dark current		ID		0.08	0.24	-	0.04	0.12	рА
Saturation charge		Qsat	-	12.5	-	-	6.3		pC
Feedback capacitance*4 of charge amplifier	High gain Low gain	Cf	1100	1 5	- 1	4 :	0.5 2.5	NAN.	PF
Dark output voltage*5	High gain Low gain	Vd	- 1	8.0 1.6	24 4.8		8.0 1.6	24 4.8	mV
Saturation output voltage	High gain Low gain	Vsat	2.8	3.2 2.5		2.8	3.2 2.5	- 1	V
Saturation exposure*6	High gain Low gain	Esat	-11	145 570	- 0		145 570		$m lx \cdot s$
of Contin	High gain		- 1	0.4 (-128Q) 0.5 (-256Q)	1.50		0.9 (-256Q) 1.3 (-512Q)	-	
Readout noise		Nr	W-1	0.8 (-512Q) 0.1 (-128Q)	21 0	- (	2.1 (-1024Q) 0.2 (-256Q)	-	
	Low gain		-	0.15 (-256Q) 0.2 (-512Q)	003	-07	0.3 (-512Q) 0.4 (-1024Q)	-	mV rms
Photo response non-unit	formity* <sup>7</sup>	PRNU	-3	- U.Z (-31ZQ)	+3	-3	-	+3	%

<sup>\*4:</sup> Vg=5 V (Low gain), Vg=0 V (High gain)

## ■ Spectral response (typical example)



Wavelength (nm)

<sup>\*3:</sup> An increased current consumption at the video terminal rises the sensor chip temperature causing an increased dark current. Connect a buffer amplifier for impedance conversion to the video terminal so that the current flowing to the video terminal is minimized.

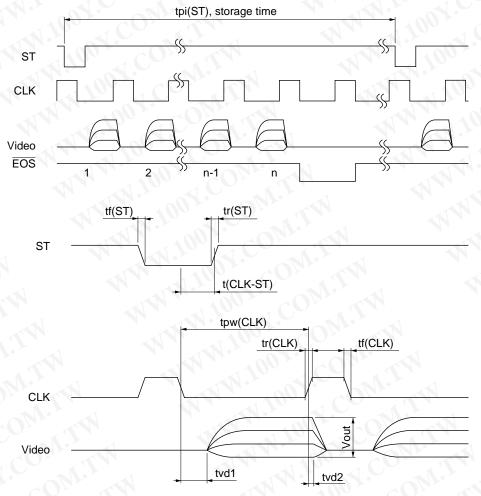
<sup>\*5:</sup> Storage time Ts=100 ms

<sup>\*6:</sup> Measured with a tungsten lamp of 2856 K.

<sup>\*7:</sup> Photo response non-uniformity is defined under the condition that the device is uniformly illuminated by light which is 50 % of the saturation exposure level as follows: PRNU=  $\Delta X/X \times 100$  (%)

X: the average output of all pixels,  $\Delta X$ : difference between X and maximum or minimum output and X

## ■ Timing chart



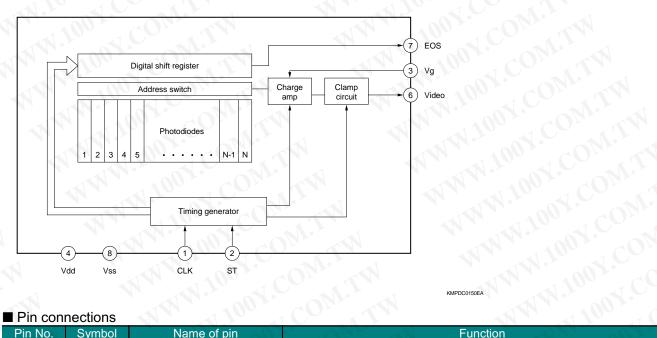
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Parameter	Symbol	Min.	Typ.	Max.	Unit
Start pulse interval	tpi(ST)	1/f × (number of pixels + 2)	CON	-	s
Start pulse rise and fall time	tr(ST), tf(ST)	0	20	30	ns
Clock pulse width	tpw(CLK)	1000 ns	160	5 ms	<
Clock pulse rise and fall time	tr(CLK), tf(CLK)	0	20	30	ns
Clock pulse-start pulse timing	t(CLK-ST)	400 ns	10 - CO.	5 ms	-
Video delay time 1	tvd1	200	300	400	ns
Video delay time 2	tvd2	50	150	250	ns

Note: The CLK pulse should be set from high to low just once when the ST pulse is low. The shift register starts operating at this timming.

The storage time is determined by the start pulse intervals. However, since the charge storage of each pixel is carried out between the signal readout of that pixel and the next signal readout of the same pixel, the start time of charge storage differs depending on each pixel. In addition, the next start pulse cannot be input until signal readout from all pixels is completed.

## ■ Block diagram



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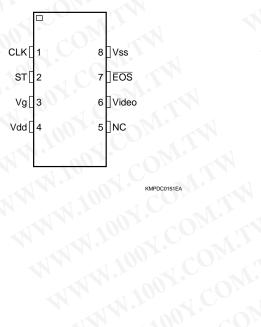
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CONTAN

## ■ Pin connections

Pulse input to operate the shift register. The readout time (data rate equals the clock pulse frequency.  Start pulse  Start pulse  Starts the shift register operation. The start pulse intervals determine the signal storage time.  Ng Gain selection voltage Input of 5 V selects "Low gain" and 0 V selects "High gain"  Vdd Supply voltage 5 V Typ.  NC Open  Video Video Signal output. Positive-going output from 1 V  Negative-going signal output obtained at a timing following the last pixe scan.				OM. TAN MAN. TOOX. COM!
Pin connections  Pin No. Symbol Name of pin Function  1 CLK Clock pulse Pulse input to operate the shift register. The readout time (data rate equals the clock pulse frequency.  2 ST Start pulse Starts the shift register operation. The start pulse intervals determine the signal storage time.  3 Vg Gain selection voltage Input of 5 V selects "Low gain" and 0 V selects "High gain"  4 Vdd Supply voltage 5 V Typ.  5 NC Open  6 Video Video Signal output. Positive-going output from 1 V  Negative-going signal output obtained at a timing following the last pixe scan.		$\circ$		M. M. M. C.
Pin connections  Pin No. Symbol Name of pin  CLK Clock pulse Pulse input to operate the shift register. The readout time (data rate equals the clock pulse frequency.  Starts the shift register operation. The start pulse intervals determine the signal storage time.  Vg Gain selection voltage Input of 5 V selects "Low gain" and 0 V selects "High gain"  Vdd Supply voltage 5 V Typ.  NC Open  Video Video Signal output. Positive-going output from 1 V  Negative-going signal output obtained at a timing following the last pixe scan.		/dd vss	CLK SI	
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signal storage time.  3  Vg Gain selection voltage Input of 5 V selects "Low gain" and 0 V selects "High gain"  4  Vdd Supply voltage 5 V Typ.  5  NC Open  6  Video Video Signal output. Positive-going output from 1 V  Negative-going signal output obtained at a timing following the last pixe scan.	1			Pulse input to operate the shift register. The readout time (data rate) equals the clock pulse frequency.
3     Vg     Gain selection voltage     Input of 5 V selects "Low gain" and 0 V selects "High gain"       4     Vdd     Supply voltage     5 V Typ.       5     NC     Open       6     Video     Signal output. Positive-going output from 1 V       7     EOS     End of scan     Negative-going signal output obtained at a timing following the last pixe scan.	2	ST	Start pulse	Starts the shift register operation. The start pulse intervals determine the
5 NC Open 6 Video Video Signal output. Positive-going output from 1 V 7 EOS End of scan Negative-going signal output obtained at a timing following the last pixe scan.	3	Vg	Gain selection voltage	
6 Video Video Signal output. Positive-going output from 1 V 7 EOS End of scan Negative-going signal output obtained at a timing following the last pixe scan.	4	Vdd	Supply voltage	5 V Typ.
7 EOS End of scan Negative-going signal output obtained at a timing following the last pixe scan.	5			Open
scan.	6	Video	Video	
8 Ves Ground	7	EOS	End of scan	Negative-going signal output obtained at a timing following the last pixe scan.
8 VSS Glouid	8	Vss	Ground	
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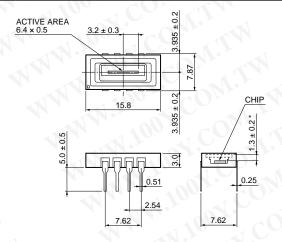
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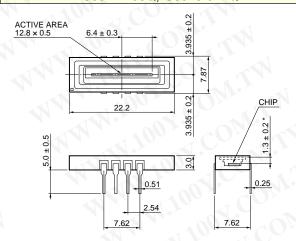
## ■ Dimensional outlines (unit: mm)

## S8377-128Q, S8378-256Q



\* Optical distance from the outer surface of the quartz window to the chip surface

## S8377-256Q, S8378-512Q

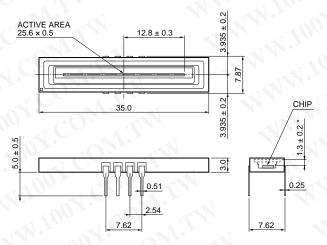


\* Optical distance from the outer surface of the quartz window to the chip surface

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KMPDA0151EC

## S8377-512Q, S8378-1024Q



\* Optical distance from the outer surface of the quartz window to the chip surface

KMPDA0152EC

## CMOS linear image sensor S8377/S8378 series

## ■ Handling precautions

## (1) Electrostatic countermeasures

Although the CMOS linear image sensor is protected against static electricity, proper electrostatic countermeasures must be provided to prevent device destruction by static electricity. For example, such measures include wearing non-static gloves and clothes, and grounding the work area and tools.

#### (2) Incident window

If the incident window is contaminated or scratched, the output uniformity will deteriorate considerably, so care should be taken in handling the window. Avoid touching it with bare hands.

The window surface should be cleaned before using the device. If dry cloth or dry cotton swab is used to rub the window surface, static electricity may be generated, and therefore this practice should be avoided. Use soft cloth, cotton swab or soft paper moistened with ethyl alcohol to wipe off dirt and foreign matter on the window surface.

#### (3) UV exposure

The CMOS linear image sensor is designed to suppress performance deterioration due to UV exposure. Even so, avoid unnecessary UV exposure to the device.

Also, be careful not to allow UV light to strike the cemented portion between the ceramic base and the glass.

## (4) Operating and storage environments

Always observe the rated temperature range when handling the device. Operating or storing the device at an excessively high temperature and humidity may cause variations in performance characteristics and must be avoided.

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HAMAMATSU PHOTONICS K.K., Solid State Division

1126-1 Ichino-cho, Higashi-ku, Hamamatsu City, 435-8558 Japan, Telephone: (81) 53-434-3311, Fax: (81) 53-434-5184, www.hamamatsu.com

U.S.A.: Hamamatsu Corporation: 360 Foothill Road, P.O.Box 6910, Bridgewater, N.J. 08807-0910, U.S.A., Telephone: (1) 908-231-0960, Fax: (1) 908-231-1218

Germany: Hamamatsu Photonics Deutschland GmbH: Arzbergerstr. 10, D-82211 Herrsching am Ammersee, Germany, Telephone: (49) 8152-265-8

France: Hamamatsu Photonics France S.A.R.L.: 19, Rue du Saule Trapu, Parc du Moulin de Massy, 91882 Massy Cedex, France, Telephone: 33-(1) 69 53 71 00, Fax: 33-(1) 69 53 71 00

United Kingdom: Hamamatsu Photonics UK Limited: 2 Howard Court, 10 Tewin Road, Welwyn Garden City, Hertfordshire AL7 1BW, United Kingdom, Telephone: (44) 1707-294888, Fax: (44) 1707-325777

North Europe: Hamamatsu Photonics Norden AB: Smidesvägen 12, SE-171 41 Solna, Sweden, Telephone: (46) 8-509-031-00, Fax: (46) 8-509-031-01

Italy: Hamamatsu Photonics Italia S.R.L.: Strada della Moia, 1/E, 20020 Arese, (Milano), Italy, Telephone: (39) 02-935-81-733, Fax: (39) 02-935-81-741

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